

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/336,424 | Applicant(s)/Patent Under Reexamination SULCER ET AL. | |
| | Examiner Hai V. Nguyen | Art Unit 2142 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-5,664,110 | 09-1997 | Green et al. | 705/26 |
| | B | US-5,761,656 | 06-1998 | Ben-Shachar, Ofer | 707/4 |
| | C | US-5,745,681 | 04-1998 | Levine et al. | 709/200 |
| | D | US-5,802,514 | 09-1998 | Huber, Val J. | 707/4 |
| | E | US-5,897,622 | 04-1999 | Blinn et al. | 705/26 |
| | F | US-5,973,696 | 10-1999 | Agranat et al. | 345/760 |
| | G | US-6,014,634 | 01-2000 | Scroggie et al. | 705/14 |
| | H | US-6,052,710 | 04-2000 | Saliba et al. | 709/203 |
| | I | US-6,249,773 | 06-2001 | Allard et al. | 705/26 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

HN